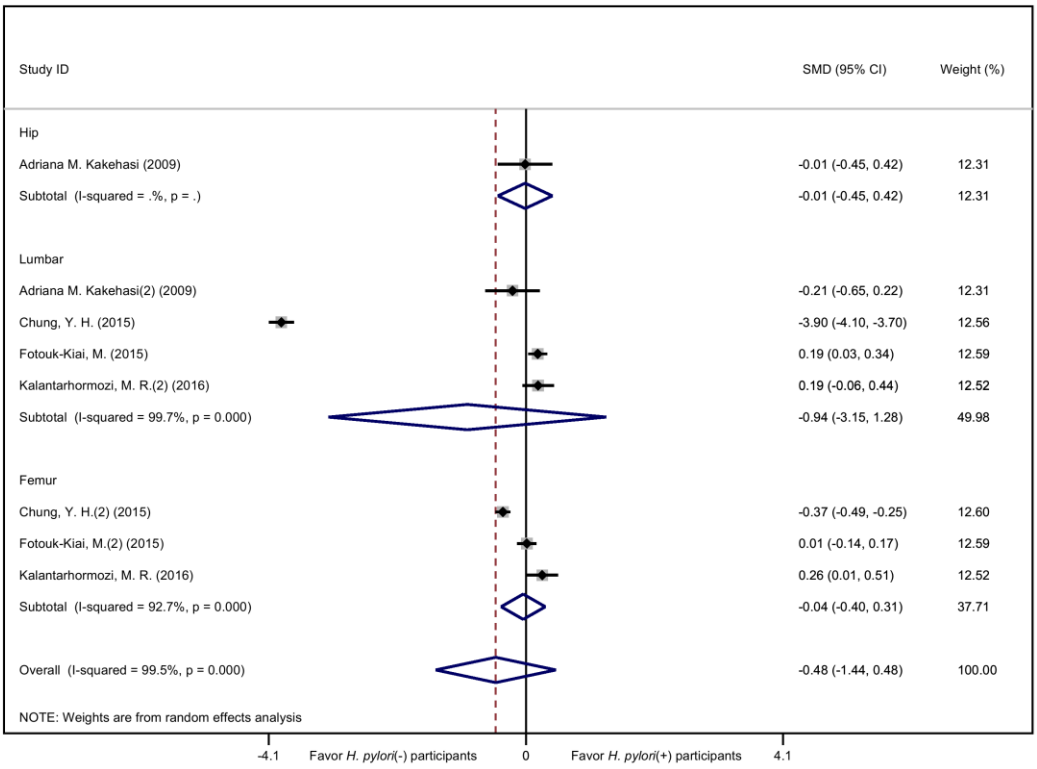

Meta-analysis of SMD according to detection locations.